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	Examiner Tran, Nguyen	Art Unit 2838

SEARCHED

Class	Subclass	Date	Examiner
320	128, 160, 137, 139, 129, 130	1/24/2007	Nguyen Tran

SEARCH NOTES

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See East Search History	1/24/2007	Nguyen Tran
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INTERFERENCE SEARCH

Class	Subclass	Date	Examiner